

Search Notes

Application/Control No.

10/728,690

Examiner

VIJAY SHANKAR

Applicant(s)/Patent under
Reexamination

ENMEI, TOSHIHARU

Art Unit

2673

SEARCHED

Class	Subclass	Date	Examiner
345	173-179	6/22/2005	VS
345	169		
178	18.01-.07		
178	19.01-.06		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as above 6/22/05 VB			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR